

Notice of References Cited	Application/Control No. 10/549,575	Applicant(s)/Patent Under Reexamination MATSUDA ET AL.	
	Examiner Aline D. McNaull	Art Unit 2872	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0100274 A1	05-2005	Yamashita et al.	385/027
*	B	US-3,498,693	03-1970	MARKIN JOSEPH; et. al.	359/317
*	C	US-3,675,154	07-1972	Duguay et al.	372/33
*	D	US-2003/0021527 A1	01-2003	Mitamura et al.	385/27
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FOREIGN PATENT DOCUMENTS

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	N	None				
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	None
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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